

TYPES 2N4851, 2N4852, 2N4853 P-N UNIJUNCTION SILICON TRANSISTORS

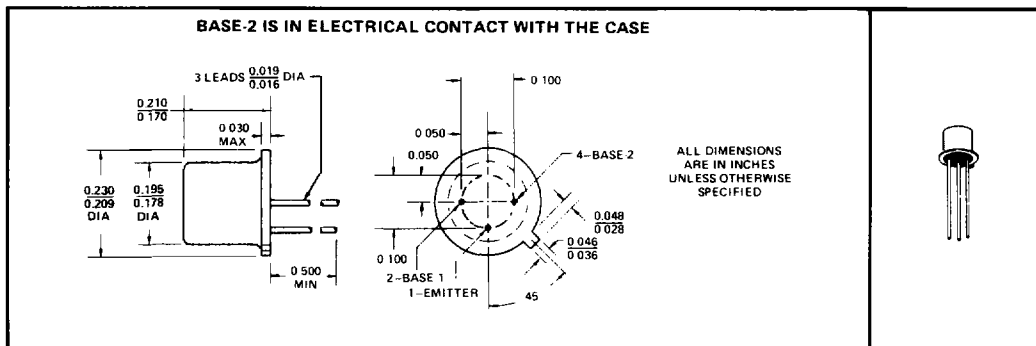
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PLANAR UNIJUNCTION TRANSISTORS SPECIFICALLY CHARACTERIZED FOR A WIDE RANGE OF MILITARY, SPACE, AND INDUSTRIAL APPLICATIONS

- Planar Process Ensures Low Leakage, High-Performance
With Low Driving Currents, and Greatly Improved Reliability

*mechanical data

Package outline is same as JEDEC TO-18 except for lead position. All TO-18 registration notes also apply to this outline.



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*absolute maximum ratings at 25°C free-air temperature (unless otherwise noted)

Emitter-Base-Two Reverse Voltage	-30 V
Interbase Voltage (See Note 1)	35 V
Continuous Emitter Current	50 mA
Peak Emitter Current (See Note 2)	1.5 A
Continuous Device Dissipation at (or below) 25°C Free-Air Temperature (See Note 3)	300 mW
Storage Temperature Range	-65°C to 200°C
Lead Temperature 1/16 Inch from Case for 10 Seconds	260°C

*electrical characteristics at 25°C free-air temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	2N4851		2N4852		2N4853		UNIT
		MIN	MAX	MIN	MAX	MIN	MAX	
r_{BB} Static Interbase Resistance	$V_{B2B1} = 3 V, I_E = 0$	4.7	9.1	4.7	9.1	4.7	9.1	k Ω
α_{rBB} Interbase Resistance Temperature Coefficient	$V_{B2B1} = 3 V, I_E = 0, T_A = -65^\circ C$ to $125^\circ C$, See Note 4	0.2	0.8	0.2	0.8	0.2	0.8	%/ $^\circ C$
η Intrinsic Standoff Ratio	$V_{B2B1} = 10 V$, See Figure 3	0.56	0.75	0.7	0.85	0.7	0.85	
I_{EB20} Emitter Reverse Current	$V_{EB2} = 30 V, I_{B1} = 0$	100		100		50		nA
I_p Peak-Point Emitter Current	$V_{B2B1} = 25 V$	2		2		0.4		μA
I_V Valley-Point Emitter Current	$V_{B2B1} = 25 V$	2		4		6		mA
V_{OB1} Base-One Peak Pulse Voltage	See Figure 4	3		5		6		V
f_{max} Maximum Frequency of Oscillation	See Figure 5	1		1		1		MHz

- NOTES: 1. The interbase voltage rating is based upon allowable power dissipation: $V_{B2B1} = \sqrt{r_{BB} \cdot P_T}$.
2. The peak emitter current rating is based on the capability of the transistor to operate safely in the circuit of Figure 4.
3. Derate linearly to 125°C free-air temperature at the rate of 3 mW/ $^\circ C$.
4. Temperature coefficient α_{rBB} is determined by the following formula:

$$\alpha_{rBB} = \left[\frac{(r_{BB} @ 125^\circ C) - (r_{BB} @ -65^\circ C)}{r_{BB} @ 25^\circ C} \right] \frac{100\%}{190^\circ C}$$

To obtain r_{BB} for a given temperature $T_{A(2)}$, use the following formula:

$$r_{BB(2)} = [r_{BB} @ 25^\circ C] [1 + (\alpha_{rBB}/100\%)(T_{A(2)} - 25^\circ C)]$$

*JEDEC registered data. This data sheet contains all applicable data in effect at the time of publication.

USES CHIP U42

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*PARAMETER MEASUREMENT INFORMATION

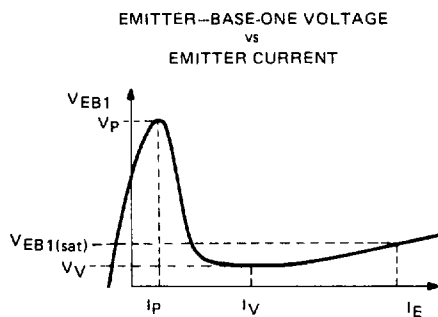


FIGURE 1—GENERAL STATIC EMITTER CHARACTERISTIC CURVE

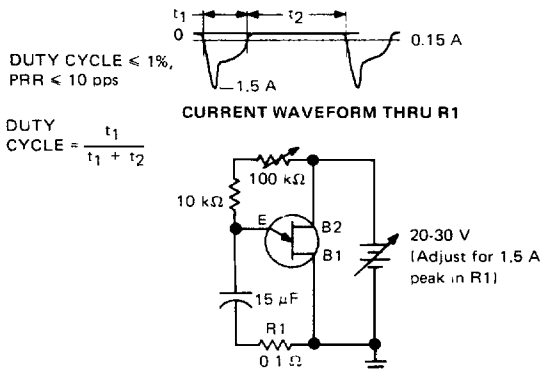


FIGURE 2—PEAK-EMITTER-CURRENT TEST CIRCUIT AND WAVEFORM

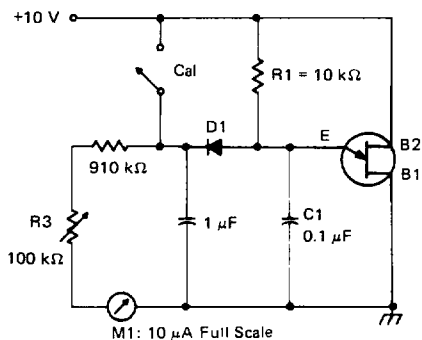


FIGURE 3—TEST CIRCUIT FOR INTRINSIC STANDOFF RATIO (η)

η —Intrinsic Standoff Ratio—This parameter is defined in terms of the peak-point voltage, V_p , by means of the equation: $V_p = \eta, V_{B2B1} + V_F$, where V_F is about 0.49 volt at 25°C and decreases with temperature at about 2 millivolts/°C.

The circuit used to measure η is shown in the figure. In this circuit, R_1 , C_1 and the unijunction transistor form a relaxation oscillator, and the remainder of the circuit serves as a peak-voltage detector with the diode D_1 automatically subtracting the voltage V_p . To use the circuit, the "cal" button is pushed, and R_3 is adjusted to make the current meter M_1 read full scale. The "cal" button then is released and the value of η is read directly from the meter, with $N = 1$ corresponding to full-scale deflection of 10 μ A.

D_1 : 1N457, or equivalent, with the following characteristics:
 $V_F = 0.49$ V at $I_F = 10$ μ A
 $I_R \leq 2$ μ A at $V_R = 20$ V

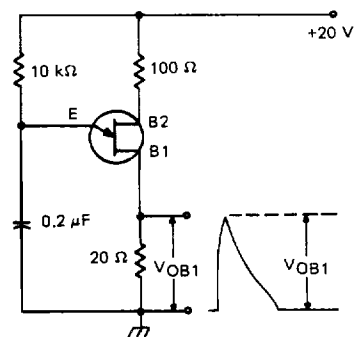
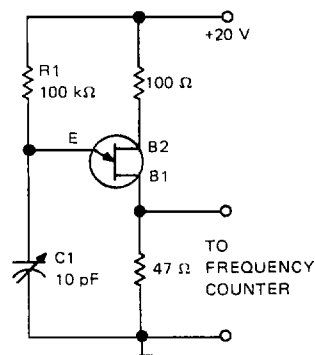


FIGURE 4— V_{OB1} TEST CIRCUIT



R_1 and C_1 are adjusted to maximize the frequency of oscillation.
 FIGURE 5— f_{max} TEST CIRCUIT

*JEDEC registered data